NAU7802 24-bit ADC

nuvoTon

NAU7802

24-Bit Dual-Channel ADC

For Bridge Sensors

Date: January, 2012

Revision 1.7

- 1 -

Nuvoton Confidential

Revision 1.7

Table of Contents

2 SYSTEM BLOCK DIAGRAM 4 3 FEATURES 4 4 APPLICATIONS 5 5 PIN CONFIGURATION 6 6 PIN DESCRIPTION 6 7 TL ONFIGURATION 6 7 TL ONFIGURATION 6 7 TL ONFIGURATION 6 7 TL ONFIGURATION 6 7 TL Absolute Maximum Ratings 7 7.1 Absolute Maximum Ratings 7 7.2 DC ELECTRICAL CHARACTERISTICS 7 7.3 RC OSC AND AC CHARACTERISTICS 7 7.4 TEMPERATURE SENSOR 9 7.5 Typical Characteristic. 10 7.5.1 NAU7802 Linearity - (Error % vs. Input Voltage) 10 7.5.2 Noise Performance - NAU7802 11 7.6 DIGITAL SERIAL INTERFACE TIMINC 12 8 FUNCTIONAL DESCRIPTION 13 8.1 Analog input (VINP, VINN, VIN2P) 13 8.2 Power supply 13<	1	GENE	ERAL DESCRIPTION	4
4 APPLICATIONS 5 5 PIN CONFIGURATION 6 6 PIN DESCRIPTION 6 7 ELECTRICAL CHARACTERISTICS 7 7.1 Absolute Maximum Ratings 7 7.2 DC ELECTRICAL CHARACTERISTICS 7 7.3 R COSC AND AC CHARACTERISTICS 7 7.4 TEMPERATURE SENSOR 9 7.5 Typical Characteristic 10 7.5.1 NAU7802 Linearity – (Error % vs. Input Voltage) 10 7.5.2 Noise Performance – NAU7802 11 7.6 DIGITAL SERIAL INTERFACE TIMING 12 7.6 DIGITAL SERIAL INTERFACE TIMING 12 8 FUNCTIONAL DESCRIPTION 13 8.1 Analog input (VINP, VINN, VIN2N, VIN2P) 13 8.2 Power supply 13 8.3 2-Wire Frotocol Convention 14 8.3.2 2-Wire Write Operation 16 8.3.3 2-Wire Streaming Data Mode 18 8.5.1 Enabling the Strearming I2C Mode RW Protocol 1	2	SYST	EM BLOCK DIAGRAM	4
4 APPLICATIONS 5 5 PIN CONFIGURATION 6 6 PIN DESCRIPTION 6 7 ELECTRICAL CHARACTERISTICS 7 7.1 Absolute Maximum Ratings 7 7.2 DC ELECTRICAL CHARACTERISTICS 7 7.3 R COSC AND AC CHARACTERISTICS 7 7.4 TEMPERATURE SENSOR 9 7.5 Typical Characteristic 10 7.5.1 NAU7802 Linearity – (Error % vs. Input Voltage) 10 7.5.2 Noise Performance – NAU7802 11 7.6 DIGITAL SERIAL INTERFACE TIMING 12 7.6 DIGITAL SERIAL INTERFACE TIMING 12 8 FUNCTIONAL DESCRIPTION 13 8.1 Analog input (VINP, VINN, VIN2N, VIN2P) 13 8.2 Power supply 13 8.3 2-Wire Frotocol Convention 14 8.3.2 2-Wire Write Operation 16 8.3.3 2-Wire Streaming Data Mode 18 8.5.1 Enabling the Strearming I2C Mode RW Protocol 1	3	FEAT	URES	4
5 PIN CONFIGURATION 6 6 PIN DESCRIPTION 6 7 ELECTRICAL CHARACTERISTICS 7 7.1 Absolute Maximum Ratings 7 7.2 DC ELECTRICAL CHARACTERISTICS 7 7.3 RC OSC AND AC CHARACTERISTICS 9 7.4 TEMPERATURE SENSOR 9 7.5 Typical Characteristic 10 7.5.1 NAU7802 Lineanty – (Error % vs. Input Voltage) 10 7.5.2 Noise Performance – NAU7802 11 7.5.3 ESD Performance – NAU7802 11 7.5.4 DIGITAL SERIAL INTERFACE TIMING 12 8 FUNCTIONAL DESCRIPTION 13 8.1 Analog input (VIN1P, VIN1N, VIN2N, VIN2P) 13 8.2 Power supply 13 8.3 2-Wire Protocol Convention 14 8.3.2 2-Wire Write Operation 16 8.3.3 2-Wire Write Operation 16 8.4.3 2-Wire Write OPeration 16 8.5.1 Enabling the Streaming 12C Mode 18 8.5.2 Streaming 12C Mode RW Protocol 1 <t< td=""><td>4</td><td></td><td></td><td></td></t<>	4			
6 PIN DESCRIPTION	5			
7 ELECTRICAL CHARACTERISTICS 7 7.1 Absolute Maximum Ratings 7 7.2 DC ELECTRICAL CHARACTERISTICS 7 7.3 RC OSC AND AC CHARACTERISTICS 9 7.4 TEMPERATURE SENSOR 9 7.5 Typical Characteristic 10 7.5.1 NAU7802 Linearity - (Erro % vs. Input Voltage) 10 7.5.2 Noise Performance - NAU7802 11 7.6 DIGITAL SERIAL INTERFACE TIMING 12 8 FUNCTIONAL DESCRIPTION 13 8.1 Analog input (VIN1P, VIN1N, VIN2N, VIN2P) 13 8.2 Power supply 13 8.3 2-Wire Virie Operation 16 8.3.3 2-Wire Write Operation 16 8.4.2 2-Wire Write Operation 16 8.5.1 Enabling the Streaming 12C Mode 18 8.5.2 Streaming 12C Mode RW Protocol 2 19 8.6 <t< td=""><td>-</td><td>-</td><td></td><td>-</td></t<>	-	-		-
7.1 Absolute Maximum Ratings 7 7.2 DC ELECTRICAL CHARACTERISTICS 7 7.3 RC OSC AND AC CHARACTERISTICS 9 7.4 TEMPERATURE SENSOR 9 7.5 Typical Characteristic 10 7.5.1 NAU7802 Linearity – (Error % vs. Input Voltage) 10 7.5.2 Noise Performance – NAU7802 11 7.5.3 SED Performance – NAU7802 11 7.6 DIGITAL SERIAL INTERFACE TIMING 12 8 FUNCTIONAL DESCRIPTION 13 8.1 Analog input (VIN1P, VIN1N, VIN2N, VIN2P) 13 8.2 Power supply 13 8.3 2-Wire Orotocl Convention 14 8.3.1 2-Wire Write Operation 16 8.3.3 2-Wire Write Operation 16 8.5.1 Enabling the Streaming I2C Mode 18 8.5.2 Streaming I2C Mode RW Protocol 1 18 8.5.3 Streaming I2C Mode RW Protocol 1 18 8.5.4 Calibration Features 20 8.6.1 Internal Band-Gap Circuit 22 8.7 Intern	-			
7.2 DC ELECTRICAL CHARACTERISTICS 7 7.3 RC OSC AND AC CHARACTERISTICS 9 7.4 TEMPERATURE SENSOR. 9 7.5 Typical Characteristic. 10 7.5.1 NAU7802 Linearity - (Error % vs. Input Voltage) 10 7.5.2 Noise Performance - NAU7802 11 7.6 DIGITAL SERIAL INTERFACE TIMING 12 8 FUNCTIONAL DESCRIPTION 13 8.1 Analog input (VIN1P, VIN1N, VIN2N, VIN2P) 13 8.2 Power supply 13 8.3.1 2-Wire Protocol Convention 14 8.3.2 2-Wire Vire Operation 16 8.3.3 2-Wire Single Read Operation 16 8.4.1 2-Wire Vire Operation 18 8.5.2 Streaming Data Mode 18 8.5.3 Streaming I2C Mode R/W Protocol 1 18 8.5.3 Streaming I2C Mode R/W Protocol 2 19 8.6 Device Calibration Features 20 8.6.1 Internal calibration. 21 8.6 Calibration Error 21 8.6 Calibration Err	•			
7.3 RC OSC AND AC CHARACTERISTICS 9 7.4 TEMPERATURE SENSOR 9 7.5 Typical Characteristic 10 7.5.1 NAU7802 Linearity - (Error % vs. Input Voltage) 10 7.5.2 Noise Performance - NAU7802 11 7.6 DIGITAL SERIAL INTERFACE TIMING 12 8 FUNCTIONAL DESCRIPTION 13 8.1 Analog input (VIN1P, VIN1N, VIN2N, VIN2P) 13 8.2 Power supply 13 8.3 2-Wire-Serial Control and Data Bus (I ² C Style Interface) 13 8.3.1 2-Wire Write Operation 16 8.3.2 2-Wire Write Operation 16 8.3.3 2-Wire Single Read Operation 16 8.5.1 Enabling the Streaming I2C Mode 18 8.5.2 Streaming I2C Mode R/W Protocol 1 18 8.5.3 Streaming I2C Mode R/W Protocol 2 19 8.6 Device Calibration Features 20 8.6.1 Internal or External calibration 20 8.6.2 Calibration Error 21 8.6.3 Calibration Error 21 <tr< td=""><td></td><td></td><td></td><td></td></tr<>				
7.4 TEMPERATURE SENSOR				
7.5 Typical Characteristic				
7.5.1 NAU7802 Linearity – (Error % vs. Input Voltage) 10 7.5.2 Noise Performance – NAU7802 11 7.5.3 ESD Performance – NAU7802 11 7.6 DIGITAL SERIAL INTERFACE TIMING 12 8 FUNCTIONAL DESCRIPTION 13 8.1 Analog input (VIN1P, VIN1N, VIN2N, VIN2P) 13 8.2 Power supply 13 8.3 2-Wire-Serial Control and Data Bus (I ² C Style Interface) 13 8.3.1 2-Wire Protocol Convention 14 8.3.2 2-Wire Write Operation 16 8.3.3 2-Wire Write Operation 16 8.3.3 2-Wire Timing 17 8.5 NAU7802 Streaming Data Mode 18 8.5.1 Enabing the Streaming 12C Mode 18 8.5.2 Streaming 12C Mode R/W Protocol 1 18 8.5.3 Streaming 12C Mode R/W Protocol 2 19 8.6 Device Calibration Features 20 8.6.1 Internal or External calibration 20 8.6.2 Calibration Error 21 8.7 Internal Crystal Oscillator 22				
7.5.2 Noise Performance – NAU7802		7.0		
7.5.3 ESD Performance – NAU7802				
7.6 DIGITAL SERIAL INTERFACE TIMING .12 8 FUNCTIONAL DESCRIPTION .13 8.1 Analog input (VIN1P, VIN1N, VIN2P) .13 8.2 Power supply .13 8.3 2-Wire-Serial Control and Data Bus (I ² C Style Interface) .13 8.3.1 2-Wire Fotocol Convention .14 8.3.2 2-Wire Write Operation .16 8.3.3 2-Wire Single Read Operation .16 8.4 2-Wire Timing .17 8.5 NAU7802 Streaming Data Mode .18 8.5.1 Enabling the Streaming I2C Mode .18 8.5.2 Streaming I2C Mode R/W Protocol 1 .18 8.5.3 Streaming I2C Mode R/W Protocol 2 .19 8.6 Device Calibration Features .20 8.6.1 Internal or External calibration. .20 8.6.2 Calibration Error .21 8.7 Internal Band-Gap Circuit .22 8.8 Reset and Power-down mode .22 8.9 Temperature sensor .23 8.10 Oscillator Features .24 8.10.1<				
8 FUNCTIONAL DESCRIPTION		7.6		
8.1 Analog input (VIN1P, VIN1N, VIN2N, VIN2P) 13 8.2 Power supply 13 8.3 2-Wire-Serial Control and Data Bus (I ² C Style Interface) 13 8.3.1 2-Wire Protocol Convention 14 8.3.2 2-Wire Write Operation 16 8.3.3 2-Wire Single Read Operation 16 8.4 2-Wire Timing 17 8.5 NAU7802 Streaming Data Mode 18 8.5.1 Enabling the Streaming I2C Mode 18 8.5.2 Streaming I2C Mode RW Protocol 1 18 8.5.3 Streaming I2C Mode RW Protocol 2 19 8.6 Device Calibration Features 20 8.6.1 Internal or External calibration 20 8.6.2 Calibration Error 21 8.6 Calibration Error 21 8.7 Internal Band-Gap Circuit 22 8.8 Reset and Power-down mode 22 8.9 Temperature sensor 23 8.10 Oscillator Features 24 8.10.1 External Clock Source 24 8.10.2 External C	8			
8.2 Power supply 13 8.3 2-Wire-Serial Control and Data Bus (I ² C Style Interface) 13 8.3.1 2-Wire Protocol Convention 14 8.3.2 2-Wire Write Operation 16 8.3.3 2-Wire Single Read Operation 16 8.4 2-Wire Timing. 17 8.5 NAU7802 Streaming Data Mode 18 8.5.1 Enabling the Streaming I2C Mode 18 8.5.2 Streaming I2C Mode R/W Protocol 1 18 8.5.3 Streaming I2C Mode R/W Protocol 2 19 8.6 Device Calibration Features 20 8.6.1 Internal or External calibration. 20 8.6.2 Calibration Limitations 21 8.6.3 Calibration Error 21 8.6.4 Calibration Error 21 8.7 Internal Band-Gap Circuit 22 8.8 Reset and Power-down mode 22 8.9 Temperature sensor 23 8.10 Oscillator Features 24 8.10.1 External Clock Source 24 8.10.2 External Clock Sourc	U			
8.3 2-Wire-Serial Control and Data Bus (I ² C Style Interface) 13 8.3.1 2-Wire Protocol Convention 14 8.3.2 2-Wire Vrite Operation 16 8.3.3 2-Wire Single Read Operation 16 8.4 2-Wire Timing 17 8.5 NAU7802 Streaming Data Mode 18 8.5.1 Enabling the Streaming I2C Mode 18 8.5.2 Streaming I2C Mode R/W Protocol 1 18 8.5.3 Streaming I2C Mode R/W Protocol 2 19 8.6 Device Calibration Features 20 8.6.1 Internal or External calibration 20 8.6.2 Calibration Error 21 8.6.3 Calibration Error 21 8.7 Internal Band-Gap Circuit 22 8.8 Reset and Power-down mode 22 8.9 Temperature sensor 23 8.10 Oscillator Features 24 8.10.1 External Cock Source 24 8.10.2 External Cock Source 24 8.10.1 External Cock Source 24 8.10.2 External Cock		••••		
8.3.1 2-Wire Protocol Convention 14 8.3.2 2-Wire Write Operation 16 8.3.3 2-Wire Single Read Operation 16 8.4 2-Wire Timing 17 8.5 NAU7802 Streaming Data Mode 18 8.5.1 Enabling the Streaming I2C Mode 18 8.5.2 Streaming I2C Mode R/W Protocol 1 18 8.5.3 Streaming I2C Mode R/W Protocol 2 19 8.6 Device Calibration Features 20 8.6.1 Internal or External calibration 20 8.6.2 Calibration Error 21 8.6.3 Calibration Error 21 8.6.3 Calibration Error 21 8.7 Internal Band-Gap Circuit 22 8.8 Reset and Power-down mode 22 8.9 Temperature sensor 23 8.10 Oscillator Features 24 8.10.1 External Clock Source 24 8.10.2 External Clock Source 24 8.10.2 External Clock Source 24 9 APPLICATION INFORMATION 25 <td></td> <td></td> <td></td> <td></td>				
8.3.2 2-Wire Write Operation 16 8.3.3 2-Wire Single Read Operation 16 8.4 2-Wire Timing 17 8.5 NAU7802 Streaming Data Mode 18 8.5 NAU7802 Streaming I2C Mode 18 8.5.1 Enabling the Streaming I2C Mode 18 8.5.2 Streaming I2C Mode R/W Protocol 1 18 8.5.3 Streaming I2C Mode R/W Protocol 2 19 8.6 Device Calibration Features 20 8.6.1 Internal or External calibration 20 8.6.2 Calibration Features 20 8.6.3 Calibration Error 21 8.6.3 Calibration Error 21 8.7 Internal Band-Gap Circuit 22 8.8 Reset and Power-down mode 22 8.9 Temperature sensor 23 8.10 Oscillator Features 24 8.10.1 External Crystal Oscillator 24 8.10.2 External Clock Source 24 9 APPLICATION INFORMATION 25 9.1 Power-On Sequencing 25 </td <td></td> <td>0.0</td> <td></td> <td></td>		0.0		
8.3.3 2-Wire Single Read Operation 16 8.4 2-Wire Timing. 17 8.5 NAU7802 Streaming Data Mode 18 8.5 NAU7802 Streaming I2C Mode 18 8.5.1 Enabling the Streaming I2C Mode 18 8.5.2 Streaming I2C Mode R/W Protocol 1 18 8.5.3 Streaming I2C Mode R/W Protocol 2 19 8.6 Device Calibration Features 20 8.6.1 Internal or External calibration 20 8.6.2 Calibration Error 21 8.6.3 Calibration Error 21 8.6.3 Calibration Error 21 8.6.4 Internal Band-Gap Circuit 22 8.7 Internal Band-Gap Circuit 22 8.8 Reset and Power-down mode 22 8.9 Temperature sensor 23 8.10 Oscillator Features 24 8.10.1 External Crystal Oscillator 24 8.10.2 External Clock Source 24 9 APPLICATION INFORMATION 25 9.1 Power-On Sequencing 25 <				
8.42-Wire Timing.178.5NAU7802 Streaming Data Mode188.5.1Enabling the Streaming I2C Mode188.5.2Streaming I2C Mode R/W Protocol 1188.5.3Streaming I2C Mode R/W Protocol 2198.6Device Calibration Features208.6.1Internal or External calibration208.6.2Calibration Limitations218.6.3Calibration Error218.7Internal Band-Gap Circuit228.8Reset and Power-down mode228.9Temperature sensor238.10Oscillator Features248.10.1External Crystal Oscillator248.10.2External Clock Source249APPLICATION INFORMATION259.1Power-On Sequencing259.2Signal path normal operation25				
8.5NAU7802 Streaming Data Mode188.5.1Enabling the Streaming I2C Mode188.5.2Streaming I2C Mode R/W Protocol 1188.5.3Streaming I2C Mode R/W Protocol 2198.6Device Calibration Features208.6.1Internal or External calibration208.6.2Calibration Limitations218.6.3Calibration Error218.7Internal Band-Gap Circuit228.8Reset and Power-down mode228.9Temperature sensor238.10Oscillator Features248.10.1External Crystal Oscillator248.10.2External Clock Source249APPLICATION INFORMATION259.1Power-On Sequencing259.2Signal path normal operation25		84		
8.5.1Enabling the Streaming I2C Mode188.5.2Streaming I2C Mode R/W Protocol 1188.5.3Streaming I2C Mode R/W Protocol 2198.6Device Calibration Features208.6.1Internal or External calibration208.6.2Calibration Limitations218.6.3Calibration Error218.7Internal Band-Gap Circuit228.8Reset and Power-down mode228.9Temperature sensor238.10Oscillator Features248.10.1External Clock Source248.10.2External Clock Source249APPLICATION INFORMATION259.1Power-On Sequencing259.2Signal path normal operation25				
8.5.2Streaming I2C Mode R/W Protocol 1.188.5.3Streaming I2C Mode R/W Protocol 2.198.6Device Calibration Features.208.6.1Internal or External calibration.208.6.2Calibration Limitations.218.6.3Calibration Error.218.6.4Internal Band-Gap Circuit.228.7Internal Band-Gap Circuit.228.8Reset and Power-down mode.228.9Temperature sensor.238.10Oscillator Features.248.10.1External Crystal Oscillator.248.10.2External Clock Source.249APPLICATION INFORMATION.259.1Power-On Sequencing.259.2Signal path normal operation.25		0.0		
8.5.3Streaming I2C Mode R/W Protocol 2198.6Device Calibration Features208.6.1Internal or External calibration208.6.2Calibration Limitations218.6.3Calibration Error218.7Internal Band-Gap Circuit228.8Reset and Power-down mode228.9Temperature sensor238.10Oscillator Features248.10.1External Crystal Oscillator248.10.2External Clock Source249APPLICATION INFORMATION259.1Power-On Sequencing259.2Signal path normal operation25				
8.6Device Calibration Features208.6.1Internal or External calibration208.6.2Calibration Limitations218.6.3Calibration Error218.7Internal Band-Gap Circuit228.8Reset and Power-down mode228.9Temperature sensor238.10Oscillator Features248.10.1External Crystal Oscillator248.10.2External Clock Source249APPLICATION INFORMATION259.1Power-On Sequencing259.2Signal path normal operation25			-	
8.6.2Calibration Limitations218.6.3Calibration Error218.7Internal Band-Gap Circuit228.8Reset and Power-down mode228.9Temperature sensor238.10Oscillator Features248.10.1External Crystal Oscillator248.10.2External Clock Source249APPLICATION INFORMATION259.1Power-On Sequencing259.2Signal path normal operation25		8.6		
8.6.3Calibration Error218.7Internal Band-Gap Circuit228.8Reset and Power-down mode228.9Temperature sensor238.10Oscillator Features248.10.1External Crystal Oscillator248.10.2External Clock Source249APPLICATION INFORMATION259.1Power-On Sequencing259.2Signal path normal operation25			8.6.1 Internal or External calibration	20
8.7Internal Band-Gap Circuit228.8Reset and Power-down mode228.9Temperature sensor238.10Oscillator Features248.10.1External Crystal Oscillator248.10.2External Clock Source249APPLICATION INFORMATION259.1Power-On Sequencing259.2Signal path normal operation25			8.6.2 Calibration Limitations	21
8.8 Reset and Power-down mode 22 8.9 Temperature sensor 23 8.10 Oscillator Features 24 8.10 Oscillator Features 24 8.10.1 External Crystal Oscillator 24 8.10.2 External Clock Source 24 9 APPLICATION INFORMATION 25 9.1 Power-On Sequencing 25 9.2 Signal path normal operation 25			8.6.3 Calibration Error	21
8.9 Temperature sensor. 23 8.10 Oscillator Features. 24 8.10.1 External Crystal Oscillator. 24 8.10.2 External Clock Source. 24 9 APPLICATION INFORMATION 25 9.1 Power-On Sequencing. 25 9.2 Signal path normal operation 25		8.7	Internal Band-Gap Circuit	
8.10 Oscillator Features 24 8.10.1 External Crystal Oscillator 24 8.10.2 External Clock Source 24 9 APPLICATION INFORMATION 25 9.1 Power-On Sequencing 25 9.2 Signal path normal operation 25		8.8	Reset and Power-down mode	
8.10.1 External Crystal Oscillator 24 8.10.2 External Clock Source 24 9 APPLICATION INFORMATION 25 9.1 Power-On Sequencing 25 9.2 Signal path normal operation 25		8.9		
8.10.2 External Clock Source		8.10	Oscillator Features	24
9 APPLICATION INFORMATION 25 9.1 Power-On Sequencing 25 9.2 Signal path normal operation 25			8.10.1 External Crystal Oscillator	24
9.1Power-On Sequencing			8.10.2 External Clock Source	24
9.2 Signal path normal operation	9	APPL	ICATION INFORMATION	
9.2 Signal path normal operation		9.1	Power-On Sequencing	
5 1		9.2		
9.3 Signal path with PGA bypass enabled		9.3	Signal path with PGA bypass enabled	

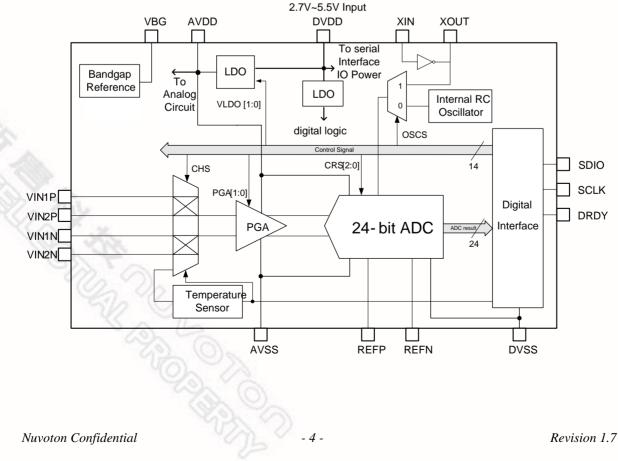
	9.4 16-pin application circuit	27
10	SUMMARY DEVICE REGISTER MAP	28
11	DEVICE REGISTER MAP DETAILS	29
	11.1 REG0x00:PU_CTRL	29
	11.2 REG0x01:CTRL1	
	11.3 REG0x02:CTRL2	
	11.4 REG0x03-REG0x05: Channel 1 OFFSET Calibration	
	11.5 REG0x06-REG0x09: Channel 1 GAIN Calibration	32
	11.6 REG0x0A-REG0x0C: Channel 2 OFFSET Calibration (NAU7802 - only)	32
	11.7 REG0x0D-REG0x10: Channel 2 GAIN Calibration (NAU7802 - only)	
	11.8 REG0x11: I2C Control	33
	11.9 REG0x12-REG0x14: ADC Conversion Result	34
	11.10 REG0x15: ADC registers	
	REG0x15-REG0x17: OTP Read Value and REG0x15 ADC Registers Read	
	11.11 REG0x18: Read Only	
	11.12 REG0x19: Read Only	
	11.13 REG0x1A: Read Only	
	11.14 REG0x1B: PGA Registers	
	11.15 REG0x1C: POWER CONTROL Register	
	11.15.1 REG0x1D: Read Only	
	11.15.2 REG0x1E: Read Only	
	11.15.3 REG0x1F: Read Only	37
12	PACKAGE DIMENSIONS	38
	12.1 16L SOP – 150 mil	38
	12.2 PDIP16L - 300 mil	39
13	PART ORDERING INFORMATION	40
14	REVISION HISTORY	41
Ŋ		17
Nuvoto	n Confidential - 3 - Revision	ı I.7

1 **GENERAL DESCRIPTION**

The Nuvoton NAU7802 is a precision low-power 24-bit analog-to-digital converter (ADC), with an onboard low-noise programmable gain amplifier (PGA), onboard RC or Crystal oscillator, and a precision 24-bit sigma-delta (Σ - Δ) analog to digital converter (ADC). The NAU7802 device is capable of up to 23-bit ENOB (Effective Number Of Bits) performance. This device provides a complete front-end solution for bridge/sensor measurement such as in weigh scales, strain gauges, and many other high resolution. low sample rate applications.

The many built-in features enable high performance applications with very low external parts count. Additionally, both operating current and standby current are very low, and many power management features are included. These enable powering only those elements of the chip that are needed, and also, to operate at greatly reduced power if the full 23-bit ENOB performance is not required.

The Programmable Gain Amplifier (PGA) provides selectable gains from 1 to 128. The A/D conversion is performed with a Sigma-Delta modulator and programmable FIR filter that provides a simultaneous 50Hz and 60Hz notch filter to effectively improve interference immunity. Also, this device provides a standard 2-wire interface compatible with I2C protocol for simple and straightforward connection to and interoperation with a wide range of possible host processors.



2 SYSTEM BLOCK DIAGRAM

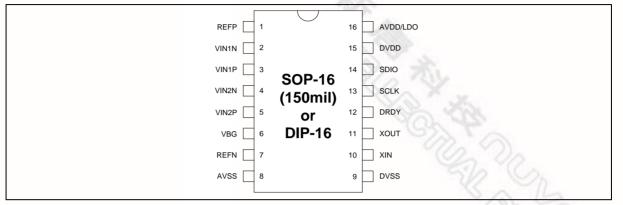
3 FEATURES

- Supply power: 2.7V~5.5V
- On-chip VDDA regulator for internal analog circuit or external load cell
 - Programmable VDDA: Off, 2.4V to 4.5V with eight options
 - Minimum 10mA output drive capability at 3.0V output voltage
 - Note: DVDD must be 0.3Vdc greater than desired VDDA output voltage
- 23 bits effective precision analog-to-digital converter
- Simultaneous 50Hz and 60Hz rejection (reaching -90dB)
- RMS Noise:
 - 50nV in 10 SPS data output rate and PGA gain = 128
 - 150nV in 80 SPS data output rate and PGA gain = 128
- Programmable PGA gains from 1 to 128
- Programmable ADC data output rates
- External differential reference voltage range from 0.1V to 5V
- System clock: External crystal oscillator or on-chip RC oscillator (4.9152Mhz)
- On-chip calibration
- On-chip power-on reset circuit
- On-chip temperature sensor
- Low Power Consumption and Programmable Power Management Options
 - I < 1uA standby current</p>
- External 4.9152MHz Crystal oscillator
- System clock:
 - Internal 4.9152MHz RC oscillator (power-on default system clock)
 - External 4.9152MHz Crystal oscillator
- MCU control interface: 2-wire interface compatible with I2C protocol
- Operating Temperature: -40~85C
- Packages:
 - SOP-16 (150mil) / PDIP-16

APPLICATIONS

- Weigh scales
- Strain Gauge
- Industrial process control
- Liquid/gas flow control
- Pressure sensors
- Voltage monitors

PIN CONFIGURATION 5



6 **PIN DESCRIPTION**

Pin No.	Pin Name	Туре	DESCRIPTIONS
1	REFP	AI	Positive reference input
2	VIN1N	AI	Inverting Input #1
3	VIN1P	AI	Non-Inverting Input #1
4	VIN2N	AI	Inverting Input #2
5	VIN2P	AI	Non-Inverting Input #2
6	VBG	Α	High impedance Reference Voltage Output and Bypass
7	REFN	AI	Negative Reference Input
8	AVSS	Р	Analog Ground
9	DVSS	Р	Digital ground
10	XIN	I	External crystal oscillator input. Typically 4.9152 MHz
11	XOUT	0	External crystal oscillator output.
12	DRDY	0	Data Ready Output indicating a conversion is complete and new data are available for readout. (CMOS Driver high / low
13	SCLK	I	Serial Data Clock Input (CMOS open drain output)
14	SDIO	I/O	Data Input / Output for serial communication with host (CMOS open drain output)
15	DVDD	Р	Digital power supply: 2.7V ~ 5.5V
16	AVDD/LDO	P	 Analog power supply: 1. From programmable LDO output, low ESR 1 ohm or lest capacitor recommended 2. LDO off: external power supply: 2.7V ~ 5.5V

• Note : TYPE P: Power, AI: Analog input, AO: Analog output, I: input, O: output, I/O: bi-directional



7 **ELECTRICAL CHARACTERISTICS**

7.1 **Absolute Maximum Ratings**

SYMBOL	PARAMETER	CONDITION	MINIMUM	MAXIMUM	UNIT
	DVDD	DVDD-DVSS	-0.3	+6.0	V
DC Power Supply	AVDD*	AVDD-AVSS	-0.3	+6.0	V
	AVSS-DVSS	-	-0.3	+0.3	V
Analog Input Voltage	AV _{IN}	AV _{IN} – AVSS	-0.3	AVDD + 0.3	V
Digital input Voltage	DV _{IN}	DV _{IN} – DVSS	-0.3	DVDD + 0.3	V
Operating Temperature	ТА		-40	+85	°C
Storage Temperature	Tst		-55	+150	°C

Note: Exposure to conditions beyond those listed under absolute maximum ratings may adversely affects the life time and reliability

* AVDD should not exceed DVDD supply voltage

DC ELECTRICAL CHARACTERISTICS 7.2

(Unless otherwise specified; Typical value is tested at TA=25°C, DVDD = 5V, AVDD = 5V)

PARAMETER		SPECI	FICATION	TEST CONDITIONS		
	MIN.	TYP.	MAX. UNIT			
POWER SUPPLY						
Operating Voltage	2.7		5.5	V	DVDD	
Operating Voltage	2.7		DVDD	V	AVDD	
Operating Current		2.1		mA	Internal OSC & LDO	
Operating Current		2		mA	Internal OSC, no LDO	
Power Down Current		0.2	1	μΑ	All analog part include internal RC oscillator or external crystal oscillator. PUA =PUD=0	

(VINxP – VINxN)	±0	.5/(VREF/P	GA)	V	VREF = REFP – REFN
Common mode range with PGA gain 64, 128	AVSS + 1.5		AVDD - 1.5	v	
Common mode range with PGA bypass enabled	AVSS - 0.1		AVDD + 0.1	v	
Differential input impedance		5		GΩ	PGA bypass=off, DC
Pondwidth (2dP)		2.27		Hz	Data output rate = 10 SPS
Bandwidth (-3dB)		18.17		Hz	Data output rate = 80 SPS
PGA	1		128	1	User-selectable gain range
Input capacitance channel 1		14		pF	Ne Sp
Input capacitance channel 2		5		pF	No. E
Differential Input leakage current		20		рА	PGA bypass=off
Burnout current sources		2.5		μA	
SYSTEM PERFORMANCE	·				292 6
Resolution		24			No missing codes
Integral nonlinearity NAU7802		± 0.0015		% of FS	With calibration
Offset error		+/-0.3		ppm of FS	With calibration, 1024 sample
Offset error drift		0.02		ppm of FS/°C	With calibration
Gain error		0.01		%	With calibration
Gain error drift		1		ppm/°C	With calibration
	96	100		dB	at DC 2.5 V ± 0.5 V
Common-mode rejection		130		dB	$f_{CM} = 60$ Hz, 500 mVpp ADC data rate = 10 SPS
		120		dB	$f_{CM} = 50$ Hz, 500 mVpp ADC data rate = 10 SPS
Notoh rojection		100		dB	$f_{CM} = 60$ Hz, 500 mVpp ADC data rate = 10 SPS
Notch rejection		100		dB	$f_{CM} = 50$ Hz, 500 mVpp ADC data rate = 10 SPS
Power supply rejection	96	100		dB	at DC 5 V \pm 0.25 V, with LDO
VOLTAGE REFERENCE INPUT					
VREF = REFP - REFN	1.5	AVDD	AVDD+. 0.1	V	
REFN input range	-0.1		VREFP- 1.5	V	
REFP input range	VREFN+ 1.5		AVDD+ 0.1		
90.90	VREFN+		AVDD+		
Nuvoton Confidential		- 8	-		Revision 1.7

DIGITAL SERIAL INTERFACE			. 335	6	
Input Leakage Current SCK, SI	-1	-	+1	μA	$DVDD = 5.5V, 0 < V_{IN} < DVDD$
Input High Voltage VIH	0.7 VDD		5.5	V	
Input low Voltage VIL	DVSS		0.3 VDD	V	
VOH (DRDY)	0.9 DVDD		No.	v	IOH = 1 mA
VOH (SCLK, SDIO)	0.9 DVDD			V	Defined by pull up resistor. (Internal weak, internal strong, external.)
VOL (SCLK, SDIO, DRDY)			0.2 DVDD	V	IOL = 1 mA
SDIO pull-up resistor Input High Voltage P1, P2, P3 (TTL input)		DVDD		V	V _{DD} = 5.5V
SDIO, SCLK; pull up resistor value	1.6 k	50 k	none	Ohm	Selectable; strong, weak, none
Power On Reset Voltage		1.6		V	

7.3 RC OSC AND AC CHARACTERISTICS

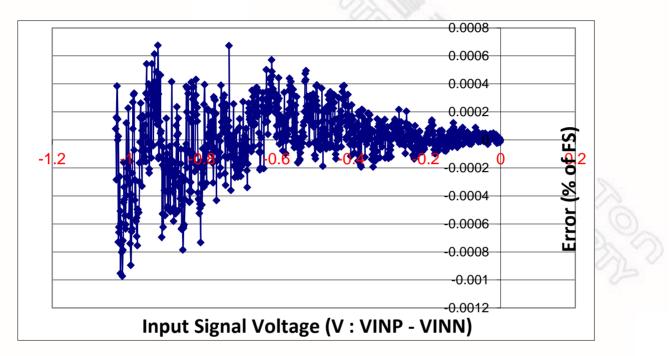
Parameter	Specification (reference)				Test Conditions
Falameter	Min.	Тур.	Max.	Unit	
4.9152 MHz On-chip RC oscillator		+/-3		%	DVDD = 5V, T=25C; NAU7802 only
T _{RDY} : Analog part wakeup stable plus Data Ready after exiting power-down mode		600		ms	DVDD = 5V; at 10 S/sec (5 sample times plus 100 ms)

7.4 TEMPERATURE SENSOR

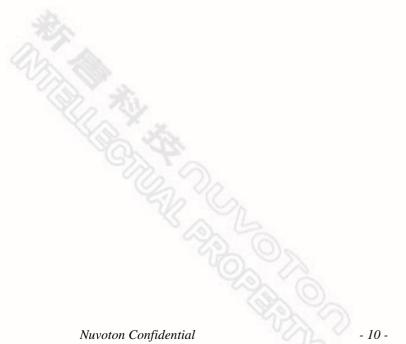
Parameter	Sp	pecification	n (referenc	Test Conditions	
Farameter	Min.	Тур.	Max.	Unit	
Temperature sensor output		109		mV	at 25°C
Temperature sensor delta coefficient		360		uV / °C	relative to 25°C

Typical Characteristic 7.5

7.5.1 NAU7802 Linearity – (Error % vs. Input Voltage) AVDD = 4.5V / PGA gain = 1x



NAU7802 Linearity Performance is symmetric, from the differential input voltage -1.2V to 0V . and from 0V to 1.2V. One-sided linearity performance result is shown.



7.5.2 Noise Performance – NAU7802

AVDD/ REFP (V)	PGA Gain	ENOB	ENOB2	NOISE_FREE_BITS				
4.5	1	22.29	22.31	20.09				
4.5	2	22.15	22.16	19.75				
4.5	4	22.01	22.02	19.61				
4.5	8	21.88	21.91	19.36				
4.5	16	21.39	21.42	18.71				
4.5	32	21.09	21.11	18.42				
4.5	64	20.42	20.43	17.89				
4.5	128	19.73	19.74	17.11				
3.3	1	21.14	21.15	19.09				
3.3	2	21.11	21.13	18.96				
3.3	4	21.1	21.1	19				
3.3	8	21.03	21.04	18.64				
3.3	16	20.8	20.81	18.19				
3.3	32	20.41	20.42	17.85				
3.3	64	19.84	19.85	17.23				
3.3	128	19.16	19.17	16.54				

NAU7802 with LDO and Cfilter=330pF on VIN2P & VIN2N at 10 S/sec

7.5.3 ESD Performance – NAU7802

Zapping Method	PD	PS	ND	NS	Remark
НВМ	4kV	4kV	-4kV	-4kV	Pass
мм	400V	400V	-400V	-400V	Pass

7.6 DIGITAL SERIAL INTERFACE TIMING

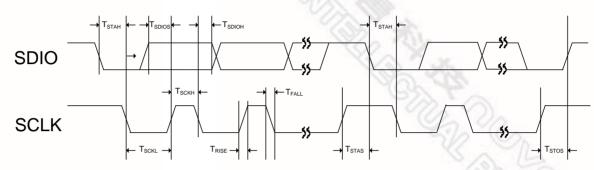


Figure 7	Two-wire Control Mode Timing
riguic r.	

Symbol	Description	min	typ	max	unit
T _{STAH}	SDIO falling edge to SCLK falling edge hold timing in START / Repeat START condition	600	-	- 5	ns
T _{STAS}	SCLK rising edge to SDIO falling edge setup timing in Repeat START condition	600	-	-	ns
T _{STOS}	SCLK rising edge to SDIO rising edge setup timing in STOP condition	600	-	-	ns
Т _{SCKH}	SCLK High Pulse Width	600	-	-	ns
T _{SCKL}	SCLK Low Pulse Width	1,300	-	-	ns
T _{RISE}	Rise Time for all 2-wire Mode Signals	-	-	300	ns
T _{FALL}	Fall Time for all 2-wire Mode Signals	-	-	300	ns
T _{SDIOS}	SDIO to SCLK Rising Edge DATA Setup Time	100	-	-	ns
T _{SDIOH}	SCLK falling Edge to SDIO DATA Hold Time	0	-	600	ns

8 FUNCTIONAL DESCRIPTION

8.1 Analog input (VIN1P, VIN1N, VIN2N, VIN2P)

The input signal to be measured is applied to one of two differential input signal pairs. The desired signal pair is selected using an analog input multiplexer, which is controlled by settings in the device command and control registers. The 8-pin version of the device supports only one input signal pair.

This device is optimized to accept differential input signals, but can also measure single-ended signals. When measuring single-ended signals with respect to ground, connect the negative input (VIN1N or VIN2N) to ground and connect the input signal to the positive input (VIN1P or VIN2P). Note that when this device is configured this way, only half of the converter full-scale range is used, since only positive digital output codes are produced.

8.2 Power supply

The digital power supply DVDD should use the same power source as used for the host processor supporting the digital interface communication. The analog power supply AVDD can be provided by external regulator output (power-on default setting) or provided by a built-in voltage regulator. The eight programmable output voltage levels of the built-in regulator are: off (high-Z output, default power-on setting), 2.4V, 2.7V, 3.0V 3.3V, 3.6V, 4.2V, and 4.5V. This output is intended to provide the driving current for external sensors such as load cells for weight measurement applications.

8.3 2-Wire-Serial Control and Data Bus (I²C Style Interface)

The serial interface provides a 2-wire bidirectional read/write data interface similar to and typically compatible with standard I2C protocol. This protocol defines any device that sends CLK onto the bus as a master, and the receiving device as slave. The NAU7802 can function only as a slave device.

An external clock drives the device, and in accordance with the protocol, data is sent to or from the device accordingly. All functions are controlled by means of a register control interface in the device. Additionally, a "data ready" output pin is provided to indicate to the host that a new conversion has been completed and that data are ready to be read from the device. The host may either use this signal or poll device register R0x00 Bit 5 to determine when new data are available.

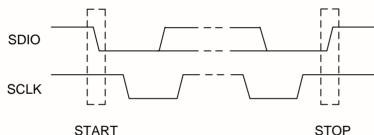
nuvoton

8.3.1 2-Wire Protocol Convention

All 2-Wire interface operations must begin with a START condition, which is a HIGH-to-LOW transition of SDIO while SCLK is HIGH. All 2-Wire interface operations are terminated by a STOP condition, which is a LOW to HIGH transition of SDIO while SCLK is HIGH. A STOP condition at the end of a read or write operation places the serial interface in standby mode.

An acknowledge (ACK), is a software convention is used to indicate a successful data transfer. To allow for the ACK response, the transmitting device releases the SDIO bus after transmitting eight bits. During the ninth clock cycle, the receiver pulls the SDIO line LOW to acknowledge the reception of the eight bits of data.

Following a START condition, the master must output a device address byte. This consists of a 7-bit device address, and the LSB of the device address byte is the R/W (Read/Write) control bit. When R/W=1, this indicates the master is initiating a read operation from the slave device, and when R/W=0, the master is initiating a write operation to the slave device. If the device address matches the address of the slave device, the slave will output an ACK during the period when the master allows for the ACK signal.







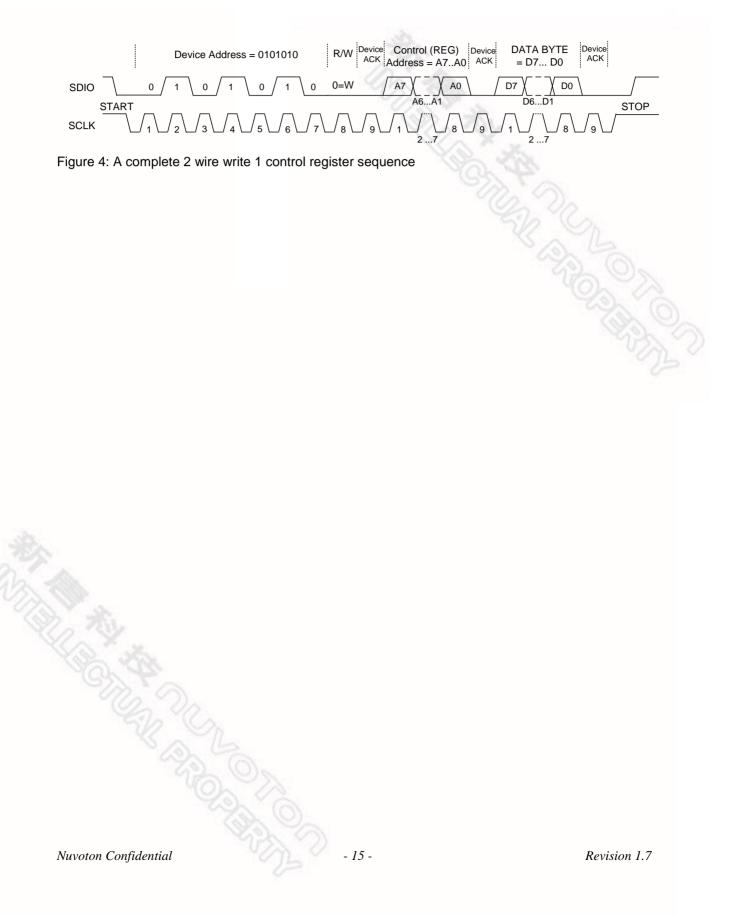
Not Acknowledge SDIO Acknowledge SCLK

Figure 2: Acknowledge and NOT Acknowledge

0	1	0	1	0	1	0	R/W	Device Address Byte
A7	A6	A5	A4	A3	A2	A1	A0	Control Address Byte
		NY.	2 0	2				
D7	D6	D5	D4	D3	D2	D1	D0	Data Byte

Figure 3: Slave Address Byte, Control Address Byte, and Data Byte

nuvoton



8.3.2 2-Wire Write Operation

A Write operation consists of a two-byte instruction followed by one or more Data Bytes. A Write operation requires a START condition, followed by a valid device address byte with R/W=0, a valid control address byte, data byte(s), and a STOP condition.

When more than one Data Byte is written, this is known as a "burst write" operation. In this operation, the host may write sequential bytes of information simply by transmitting a new data byte after each ACK from the NAU7802. The NAU7802 automatically increments the register address by one for each subsequent byte-write operation. This will continue until the STOP condition is met.

The NAU87802 is permanently programmed with "010 1010" (0x2A) as the Device Address. If the Device Address matches this value, the NAU7802 will respond with the expected ACK signaling as it accepts the data being transmitted into it.

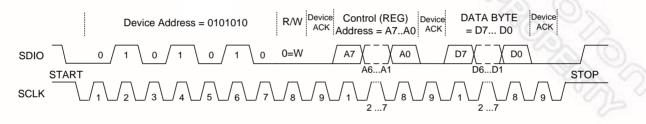
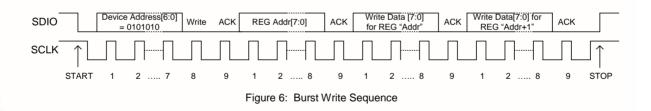


Figure 5: Single Write Sequence



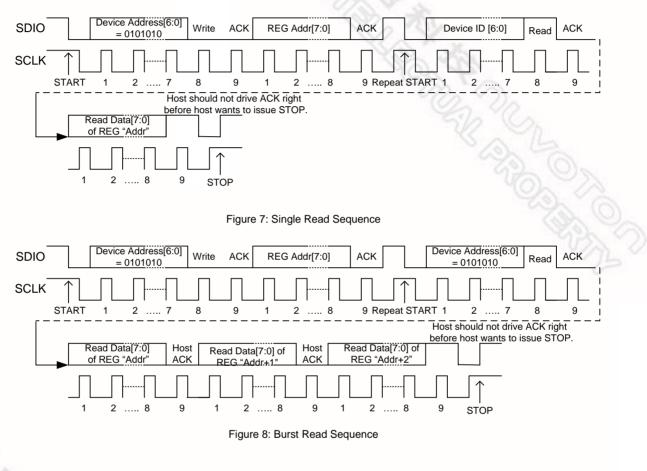
8.3.3 2-Wire Single Read Operation

A Read operation consists of a three-byte Write instruction followed by a Read instruction of one or more data bytes. The bus master initiates the operation issuing the following sequence: a START condition, device address byte with the R/W bit set to "0", and a Control Register Address byte. This indicates to the slave device which of its control registers is to be accessed.

The NAU7802 is permanently programmed with "010 1010" (0x2A) as its device address. If the device address matches this value, the NAU7802 will respond with the expected ACK signaling as it accepts the Control Register Address being transmitted into it. After this, the master transmits a second START condition, and a second instantiation of the same device address, but now with R/W=1.

After again recognizing its device address, the NAU7802 transmits an ACK, followed by a one byte value containing the data from the selected control register inside the NAU7802. During this phase, the master generates the ACK signaling with each byte transferred from the NAU7802. If there is no STOP signal from the master, the NAU7802 will internally auto-increment the target Control Register Address and then output the data bytes for this next register in the sequence.

This process will continue while the Master continues to issue ACK signaling. If the Control Register Address being indexed inside the NAU7802 reaches the value 0x7F (hexadecimal) and the value for this register is output, the index will roll over to 0x00. The data bytes will continue to be output until the master terminates the read operation by issuing a STOP condition.



8.4 2-Wire Timing

Please see electrical specifications

The NAU7802 is compatible with serial clock speeds defined as "standard mode" with SCLK 0 - 100 kHz, and "fast mode" with SCLK 0 - 400 kHz. At these speeds the total bus line capacitance load is required to be 400 pF or less.

Open collector drivers are required for the serial interface. Therefore, the bus line rise time is determined by the total serial bus capacitance and the DVDD pull-up resistors. The NAU7802 defaults to a weak pull up (typical 50 k ohm) for applications with no external pull up resistor. Register 0x11 bits 5:4 provide other options including a strong internal pull-up (typical 1.6 k ohm) or no internal pull-up resistor.

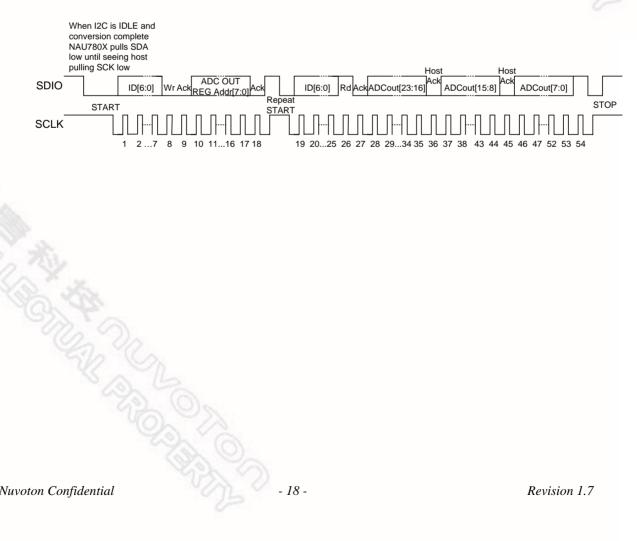
8.5 NAU7802 Streaming Data Mode

8.5.1 **Enabling the Streaming I2C Mode**

- Power Up the chip
 - Write 0x00 = 0x06 (PU analog and PU digital)
 - \circ (read back 0x00 bit 3 to make sure chip is powered up)
- Enable Streaming I2C Mode
 - Write REG11[7]=1 to enable streaming mode 1, or Write REG11[7]=1 and REG11[6]=1 and REG15[7]=1 to enable streaming mode 2
 - (read back 0x1D bit 7 to make sure the streaming I2C mode is active) 0

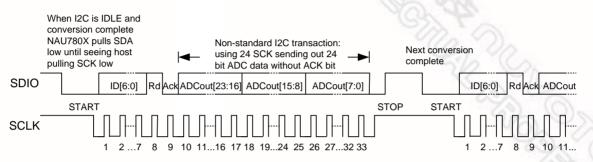
Streaming I2C Mode R/W Protocol 1 8.5.2

When REG0x11[7] CRSD=1, I2C is IDLE and a conversion is complete, NAU7802 will pull SDA/SDIO low to inform the host a conversion is complete. Host should respond by pulling SDA/SDIO low and pulling SCK low to initial an I2C "start" condition. When seeing SCK pulled low by host, NAU7802 will release the SDA/SDIO. Host can continue the standard I2C transaction with NAU7802



8.5.3 Streaming I2C Mode R/W Protocol 2

In addition to CASE1 REG11[7]=1, if REG0x11[6] FRD=1 and REG0x15[7]=1, host can direct issue a I2C read cycle (No writing register address first needed), after the Ack bit for the ID and "Read Select", the following 24 SCK is used for NAU7802 to shift out the 24 bit ADC conversion result without the ACK bit needed. So the total Read ADC conversion data cycle can be shorten to 33 SCK comparing to 54 SCK plus a repeat start by using the standard I2C.



Note: Write NAU7802 register is always allowed by using Standard I2C write NAU7802 register protocol. So these two special bits can be reset to 0 to return to Standard I2C protocol

A STORE LAND - 19 -Nuvoton Confidential

8.6 Device Calibration Features

Calibration is not required for low accuracy applications, but may be needed in sensitive applications. When calibration is used the system designer has three options.

Calibration can be performed at the system level with an external processor or at the ADC device. Inside the ADC device both internal and external calibration can be performed.

Internal ADC device calibration only removes internal PGA gain and offset errors. External ADC device calibration removes DC errors at the device input pins and the internal PGA gain and offset errors.

As with all devices of this type, the NAU7802 internal gain factors and offset voltages will contain small errors owing to fabrication process variations, power supply voltage changes, and temperature variations. The same types of errors exist at the external system level.

These errors can be measured by the NAU7802 device itself using the calibration features. After calibration, the stored values in the calibration registers are automatically added/subtracted to the data from the ADC before being output as the ADC resulting data. It is recommended to calibrate the NAU8702 after the following conditions:

- Initial power-up
- Power-up after long-duration register mediated power-down conditions
- PGA gain changes
- Supply changes
- Significant temperature changes (can be measured using built-in thermal sensing feature)
- Sample rate changes
- Channel select changes

Calibration is initiated by writing Logic=1 to R0x02 Bit 2. Bit 2 named "CALS" then becomes a status bit that can be read to know when calibration is complete. Internal or external calibration is performed on the Gain or Offset value and input channel as selected by other bits in R0x02. Bit 2 will remain Logic=1 until calibration is complete, and will read back as Logic=0 when calibration is completed.

After calibration, it is important to check the CAL_ERR status bit to determine if there was any problem during calibration. If there was an error, all data output could be invalid.

8.6.1 Internal or External calibration

The internal calibration disconnects the inputs from the input pins and internally connects the differential inputs to the same internal voltage reference point for calibration. the internal inputs for offset calibration. External calibration uses the inputs as-is, and it is up to the system designer to configure them appropriately for the calibration procedure. The resulting gain or offset calibration value is stored in the selected calibration register. The same register sets are used for both internal or external calibration and it is intended that only one choice of internal/external calibration is used at any given time.

nuvoton

At all times, when reading a value from the ADC registers, the gain and offset calibration values are added/subtracted to the ADC value before being output. The default values for the calibration registers is zero, so these have no affect on the ADC output value until after a calibration operation has been instantiated.

The resulting output value is calculated as:

ADC Output Value = Gain_Calibration* (ADC measurement - Offset_Calibration)

Calibration Equations

OFFSET=(1-b23) x (b22*2⁻¹+b21*2⁻²+b20*2⁻³+b19*2⁻⁴+b18*2⁻⁵+b17*2⁻⁶+b16*2⁻⁷+b15*2⁻⁸+b14*2⁻⁹+b13*2⁻¹⁰+b12*2⁻¹¹

 $+b11*2^{-12}+b10*2^{-13}+b9*2^{-14}+b8*2^{-15}+b7*2^{-16}+b6*2^{-17}+b5*2^{-18}+b4*2^{-19}+b3*2^{-20}+b2*2^{-21}+b1*2^{-22}+b0*2^{-23})$ GAIN=b31*2^8+b30*2^7+b29*2^6+b28*2^5+b27*2^4+b26*2^3+b25*2^2+b24*2^1+b23*2^0+b22*2^{-1}+b21*2^{-2}+b20*2^{-3}+b19*2^{-4}+b18*2^{-5}+b17*2^{-6}+b16*2^{-7}+b15*2^{-8}+b15*

 $+b14*2^{-9}+b13*2^{-10}+b12*2^{-11}+b11*2^{-12}+b10*2^{-13}+b9*2^{-14}+b8*2^{-15}+b7*2^{-16}+b6*2^{-17}+b5*2^{-18}+b4*2^{-19}+b3*2^{-20}+b2*2^{-21}+b1*2^{-22}+b0*2^{-23}+b1*2^{-24}+b1*2$

DOUT<23:0>'=(DOUT<23:0>+OFFSET<23:0>) x GAIN<31:0>

8.6.2 Calibration Limitations

Note that the offset that is trimmed from the input is mapped through the gain register. Additionally:

- Calibration can be limited by signal headroom in the analog path
- With the converters intrinsic gain & offset error the minimal full scale input range may be higher or lower.

8.6.3 Calibration Error

A calibration error may occur during gain calibration when one of the following happens:

- The gain required to map input to full scale is larger than the range available in the gain register ~ 256
- The offset adjusted input is negative, e.g. 256 > gain > 0

If there is a calibration error, CAL_ERR will set to Logic=1 when the calibration sequence is completed. Once CAL_ERR is set to Logic=1, it will remain in this state until either the NAU7802 is reset, or after a valid calibration sequence is completed.

When $CAL_ERR = 1$, the data in the calibration registers is invalid. It is recommended perform the calibration routine again, or to write a default value into the calibration registers.

8.7 **Internal Band-Gap Circuit**

An internal band-gap establishes accurate operation of the device over a wide temperature range. No adjustment of the bandgap is necessary. For optimum performance, the NAU7802 makes available a band-gap output pin "VBG" which should be bypassed to ground with a high quality X7R small value 0.1 uF filter capacitor.

8.8 Reset and Power-down mode

An automatic built-in power-on reset function will reset the NAU7802 after DVDD power becomes valid. After AVDD power is stable (from external power or from the built-in regulator), reset may also be initiated at any time using the register control interface. The scope of the register based reset using register 0x00 bit 0, named "RR" set to 1, is equivalent to the power-on reset.

Power-down standby mode can be selected using the register control interface using register 0x00 bits 2:1, named "PUA" and "PUD" set to 0. This mode shuts down the entire analog portion of the part, including the 24-bit ADC, voltage regulator, PGA, bandgap reference, and internal RC oscillator (or external crystal oscillator) to reduce power consumption.

The command and control interface is static and works normally in power-down mode. Power-down mode can be terminated at any time by changing the register controls to return the device to normal operating mode, using register 0x00 bits 2:1, named "PUA" and "PUD" set to 1. In this way the contents of the registers are retained for immediate normal use.

After reset or after resuming normal operating mode after power-down mode, the host should wait through six cycles of data conversion. This allows the device to stabilize all functions and to flush all old internal data for a full-accuracy output. This timing is automatically generated by the device for the DRDY pin and Data Ready device status bit.

8.9 Temperature sensor

A matched pair of on-chip diodes provides temperature sensing capability. Temperature sensing is selected by setting of the analog input multiplexer using the register control interface. A PGA gain of 2x or 1x is used for temperature sensing to prevent PGA clipping.

By measuring the difference in voltage of these diodes, temperature changes can be inferred from a baseline temperature. Please refer to the specification items "Temperature sensor output" and "Temperature sensor delta coefficient."

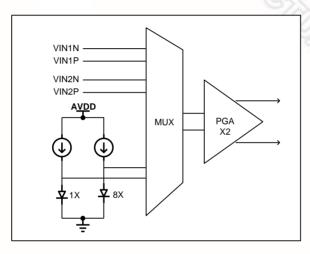


Figure 8



8.10 Oscillator Features

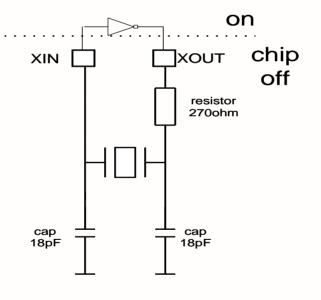
This device may either accept an external clock, use an internal RC oscillator, or use a built-in crystal oscillator for its time base. An accurate clock is important for the digital filtering of 50Hz or 60Hz components to work optimally. The internal oscillator is trimmed at the factory for good accuracy.

The internal RC or crystal oscillator frequency may be output on the DRDY pin. This is done by programming R0x06 as follows:

- Write REG00[6] = 0: Use oscillator as system clock
- Write REG01[6] = 1: Output system clock on DRDY pin

8.10.1 External Crystal Oscillator

When an external 4.9152MHz crystal oscillator is used, the preferred application circuit on the XIN & XOUT pins is as shown below. The crystal oscillator could operate without the 270 Ohm resistor and without the 18pF capacitor on XIN at a reduced performance.



8.10.2 External Clock Source

When the clock for the NAU7802 may also be provided from an external source. To use this feature, the device is configured in the same way as for using a crystal and the external clock signal is applied to the XIN pin.

9 APPLICATION INFORMATION

This section includes both circuit diagram information and recommendations for programming the device. Programming is essential, as the device will not function until various default settings are changed to values appropriate for the application.

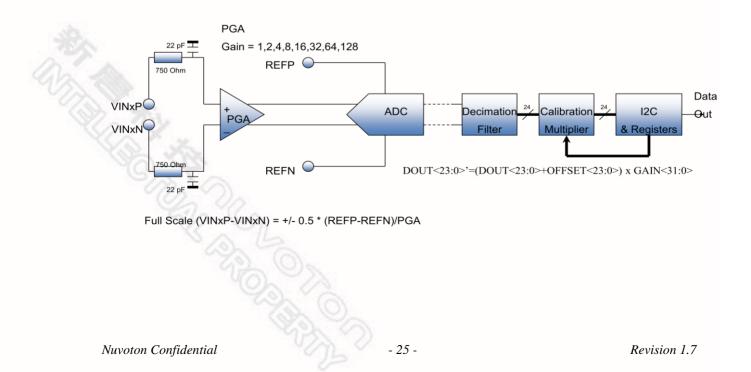
9.1 Power-On Sequencing

After the DVDD supply is valid, and after the internal power-on reset is completed, the NAU7802 is ready for host program control access. The following steps apply to most applications.

- 1. Set the RR bit to 1 in R0x00, to guarantee a reset of all register values.
- 2. Set the RR bit to 0 and PUD bit 1, in R0x00, to enter normal operation
- 3. After about 200 microseconds, the PWRUP bit will be Logic=1 indicating the device is ready for the remaining programming setup.
- 4. At this point, all appropriate device selections and configuration can be made.
 - a. For example R0x00 = 0xAE
 - b. R0x15 = 0x30
- 5. No conversion will take place until the R0x00 bit 4 "CS" is set Logic=1
- 6. Enter the low power standby condition by setting PUA and PUD bits to 0, in R0x00
- 7. Resume operation by setting PUA and PUD bits to 1, in R0x00. This sequence is the same for powering up from the standby condition, except that from standby all of the information in the configuration and calibration registers will be retained if the power supply is stable. Depending on conditions and the application, it may be desirable to perform calibration again to update the calibration registers for the best possible accuracy.

9.2 Signal path normal operation

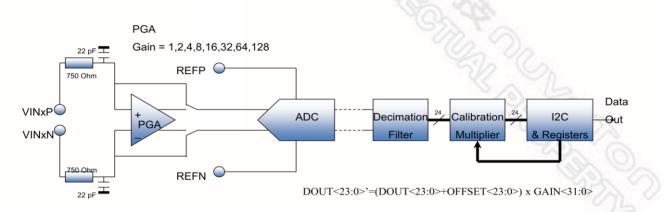
In normal operation the input signal is full scale at the ADC input when (VINxP - VINxN) = +/-0.5 * (REFP - REFN) / PGA Gain, within the PGA common mode range.



Signal path with PGA bypass enabled 9.3

Register 0x1B bit 4, "PGA bypass enable" removes the PGA from the signal path in applications where VINxP or VINxN approach AVDD or AVSS. Because the PGA has a limited common mode input range. In this range the PGA can be bypassed.

In PGA bypass operation the input signal is full scale at the ADC input when (VINxP - VINxN) = +/- 0.5 * (REFP - REFN) within the ADC common mode range.



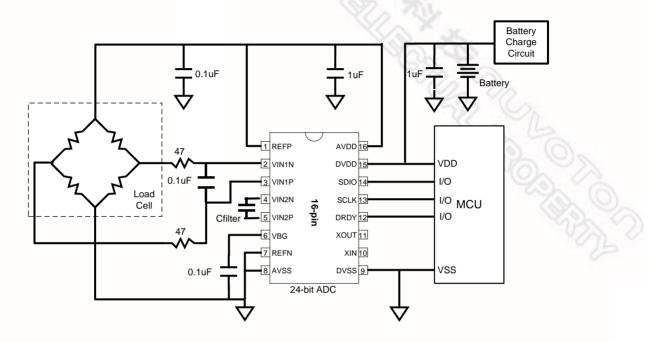
Full Scale (VINxP-VINxN) = +/- 0.5 * (REFP-REFN)

- 26 -

nuvoton

9.4 16-pin application circuit

The built-in voltage regulator and built-in oscillator enable very low parts count applications as shown here. The signal input filter is optional, depending on the application requirements and can be expanded with decoupling capacitors to ground if needed. With a lithium-ion battery, an external voltage regulator for the DVDD supply may also be optional.



For single channel applications, Cfilter can be added for enhanced ENOB at high PGA gain settings. The filter capacitor Cfilter provides additional filtering at the PGA output. It can be enabled by setting PGA_CAP_EN, Register 0x1C[7]=1. The following values are recommended for Cfilter:

AVDD Supply Voltage (Volt)	3.3	4.5
Cfilter (pF)	330	680

10 SUMMARY DEVICE REGISTER MAP

	Address	Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	Default
	0x00	<u>PU CTRL</u>	AVDDS	OSCS	CR	CS	PUR	PUA	PUD	RR	0x00
	0x01	CTRL1	CRP		VLDC	D[2:0]		GAINS	[2:0]		0x00
	0x02	CTRL2	CHS	CRS[1	:0]			CALS	CALM	OD[1:0]	0x00
	0x03	OCAL1_B2	CH1 OF	FSET (Calibra	ation[2	23:16]	6	222	A	0x00
	0x04	OCAL1_B1	CH1 OF	FSET (Calibra	ation[1	15:8]		× (0),	~ 0	0x00
	0x05	OCAL1_B0	CH1 OF	FSET (Calibra	ation[7	7:0]		5	6	0x00
	0x06	GCAL1_B3	CH1 GA	IN Cali	bratio	n[31:2	24]			50	0x00
	0x07	GCAL1 B2	CH1 GA	IN Cali	bratio	n[23:1	6]			N.	0x80
	0x08	GCAL1_B1	CH1 GA	IN Cali	bratio	n[15:8	3]				0x00
	0x09	GCAL1 B0	CH1 GA	IN Cali	bratio	n[7:0]					0x00
	0x0A	OCAL2_B2	CH2 OF	FSET (Calibra	ation[2	23:16]				0x00
	0x0B	OCAL2_B1	CH2 OF	FSET (Calibra	ation[1	15:8]				0x00
	0x0C	OCAL2_B0	CH2 OF	FSET (Calibra	ation[7	7:0]				0x00
	0x0D	GCAL2_B3	CH2 GA	IN Cali	bratio	n[31:2	24]				0x00
	0x0E	GCAL2_B2	CH2 GA	IN Cali	bratio	n[23:1	6]				0x80
	0x0F	GCAL2_B1	CH2 GA	IN Cali	bratio	n[15:8	3]				0x00
	0x10	GCAL2_B0	CH2 GA	IN Cali	bratio	n[7:0]					0x00
	0x11	I2C Control	CRSD	FDR	SPE/	WPD	SI	BOPGA	A TS/B	GPCP	0x00
	0x12	ADCO_B2	ADC_O	UT[23:1	6]						RO
	0x13	ADCO_B1	ADC_O	UT[15:8	3]						RO
	0x14	ADCO_B0	ADC_O	UT[7:0]							RO
	0x15	<u>OTP_B1</u>	OTP[15:	:8]							RO
	0x16	OTP_B0	OTP[7:0)]							RO
	0x1F		Device F	Revisior	n Cod	е					RO
Nuvoton	Confidenti	al			- 28	-					Revisi

11 DEVICE REGISTER MAP DETAILS

11.1 REG0x00:PU_CTRL

Register Default = 0x00

AVDDS OSCS CR CS PUR PUA	AVDD source select 1 = Internal LDO 0 = AVDD pin input (default) System clock source select 1 = External Crystal 0 = Internal RC oscillator (default) Cycle ready (Read only Status) 1 = ADC DATA is ready Cycle start Synchronize conversion to the rising edge of this register Power up ready (Read Only Status) 1 = Power Up ready 0 = Power down, not ready Power up analog circuit 1 = Power up the chip analog circuits (PUD must be 1) 0 = Power up digital circuit Power up digital circuit
CR CS PUR PUA	 1 = External Crystal 0 = Internal RC oscillator (default) Cycle ready (Read only Status) 1 = ADC DATA is ready Cycle start Synchronize conversion to the rising edge of this register Power up ready (Read Only Status) 1 = Power Up ready 0 = Power down, not ready Power up analog circuit 1 = Power up the chip analog circuits (PUD must be 1) 0 = Power up digital circuit
CS PUR PUA	 1 = ADC DATA is ready Cycle start Synchronize conversion to the rising edge of this register Power up ready (Read Only Status) 1 = Power Up ready 0 = Power down, not ready Power up analog circuit 1 = Power up the chip analog circuits (PUD must be 1) 0 = Power down (default) Power up digital circuit
PUR PUA	Synchronize conversion to the rising edge of this register Power up ready (Read Only Status) 1 = Power Up ready 0 = Power down, not ready Power up analog circuit 1 = Power up the chip analog circuits (PUD must be 1) 0 = Power down (default) Power up digital circuit
PUA	 1 = Power Up ready 0 = Power down, not ready Power up analog circuit 1 = Power up the chip analog circuits (PUD must be 1) 0 = Power down (default) Power up digital circuit
	 1 = Power up the chip analog circuits (PUD must be 1) 0 = Power down (default) Power up digital circuit
חוופ	
	1 = Power up the chip digital logic 0 = power down (default)
RR	Register reset 1 = Register Reset, reset all register except RR 0 = Normal Operation (default) RR is a level trigger reset control. RR=1, enter reset state, RR=0, leave reset state back to normal state.
	2

11.2 REG0x01:CTRL1

Register Default= 0x00

	Bit	Name	Description	
	7	CRP	Conversion Ready Pin Polarity (16 Pin Package Only) 1=CRDY pin is LOW Active (Ready when 0) 0=CRDY pin is High Active(Ready when 1) (default)	
	6	DRDY_SEL	Select the function of DRDY pin 1: DRDY output the Buffered Crystal Clock if OSCS=1 output the internal OSC clock if OSCS= 0 0: DRDY output the conversion ready (default)	4
	5:3	VLDO	LDO Voltage 111 = 2.4 110 = 2.7 101 = 3.0 100 = 3.3 011 = 3.6 010 = 3.9 001 = 4.2 000 = 4.5 (default)	
	2:0	GAINS	Gain select 111 = x128 110 = x64 101 = x32 100 = x16 011 = x8 010 = x4 001 = x2 000 = x1 (default)	
Nuvoton C	Confi	l		evision 1.7

11.3 REG0x02:CTRL2

Register Default =0x00

E	Bit Name	Description
7	CHS	Analog input channel select 1 = Ch2 0 = Ch1 (default)
6	:4 CRS	Conversion rate select 111 = 320SPS 011 = 80SPS 010 = 40SPS 001 = 20SPS 000 = 10SPS (default)
3	CAL_ERR	Read Only calibration result 1: there is error in this calibration 0: there is no error
2	CALS	Write 1 to this bit will trigger calibration based on the selection in CALMOD[1:0] This is an "Action" register bit. When calibration is finished, it will reset to 0 While this bit is still 1, the chip is still calibrating. An I2C write to this bit will be ignored and no additional calibration will be triggered
*	:0 CALMOD	 11 = Gain Calibration System 10 = Offset Calibration System 01 = Reserved 00 = Offset Calibration Internal (default)
Nuvoton Confid	ential	- 31 - Rev

11.4 REG0x03-REG0x05: Channel 1 OFFSET Calibration

										offse	et reg	giste	r											
bit	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
offset	+/-	2 ⁻¹	2 ⁻²	2 ⁻³	2-4	2 ⁻⁵	2 ⁻⁶	2-7	2 ⁻⁸	2 ⁻⁹	2 ⁻¹⁰	2 ⁻¹¹	2 ⁻¹²	2 ⁻¹³	2 ⁻ 14	2 ⁻ 15	2 ⁻ 16	2 ⁻ 17	2 ⁻ 18	2 ⁻ 19	2 ⁻ 20	2 ⁻ 21	2 ⁻ 22	2 ⁻ 23
default	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

11.5 REG0x06-REG0x09: Channel 1 GAIN Calibration

													gai	in re	egis	ster								2	6	ĩ						
bit	31	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
gain	2 ⁸	2 ⁷	2 ⁶	2 ⁵	2 ⁴	2 ³	2 ²	2 ¹	2 ⁰	2 ⁻	2 ⁻ 2	2 ⁻ 2	2⁻ ₃	2 ⁻	2 ⁻ 5	2 ⁻	2 ⁻	2 ⁻	2 ⁻ 9	2 ⁻ 10	2 ⁻ 11	2 ⁻ 12	2 ⁻ 13	2 ⁻ 14	2 ⁻ 15	2 ⁻ 16	2 ⁻ 17	2 ⁻ 18	2 ⁻ 19	2 ⁻ 20	2 ⁻ 21	2 ⁻²²
default	0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

11.6 REG0x0A-REG0x0C: Channel 2 OFFSET Calibration (NAU7802 - only)

Register Default = 0x000000

									(offse	et reg	giste	r											
bit	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
offset	+/-	2 ⁻¹	2 ⁻²	2 ⁻³	2 ⁻⁴	2 ⁻⁵	2 ⁻⁶	2 ⁻⁷	2 ⁻⁸	2 ⁻⁹	2 ⁻¹⁰	2 ⁻¹¹	2 ⁻¹²	2 ⁻¹³	2⁻ 14	2⁻ 15	2⁻ 16	2 ⁻ 17	2⁻ 18	2 ⁻ 19	2 ⁻ 20	2⁻ 21	2 ⁻ 22	2 ⁻ 23
default	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

11.7 REG0x0D-REG0x10: Channel 2 GAIN Calibration (NAU7802 - only)

Register Default = 0x00800000

													gai	n re	egis	ter																
bit	31	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
gain	2 ⁸	2 ⁷	2 ⁶	2 ⁵	2 ⁴	2 ³	2 ²	2 ¹	2 ⁰	2 ⁻	2 ⁻ 2	2 ⁻ 2	2⁻ ₃	2 ⁻ 4	2 ⁻ 5	2 ⁻	2 ⁻ 7	2 ⁻ 8	2 ⁻ 9	2 ⁻ 10	2 ⁻ 11	2 ⁻ 12	2 ⁻ 13	2 ⁻ 14	2 ⁻ 15	2 ⁻ 16	2 ⁻ 17	2 ⁻ 18	2 ⁻ 19	2 ⁻ 20	2 ⁻ 21	2 ⁻²²
default	0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

11.8 REG0x11: I2C Control

	t Name	Description
7	CRSD	Enable bit for Pull SDA low when conversion complete and I2C IDLE(special non-standard I2C) 1 = enable 0 = disable (default)
6	FRD	Enable bit for Fast Read ADC DATA (special non-standard I2C) 1 = enable fast read ADC Data special non-standard I2C feature 0 = disable fast read ADC Data feature(default) REG0x15 bit 7 must be also set to 1 in order to have this function to work
5	SPE	Enable bit for Strong Pull Up for I2C SCLK and SDA 1 = enable strong pull up (nominal 1.6 k ohm) 0 = disable strong pull up (default)
4	WPD	Disable bit for Weak Pull Up for I2C SCLK and SDA 1 = disable weak pull up 0 = enable weak pull up (default nominal 50 k ohm)
3	SI	Short the input together, measure offset
2		Enables the 2.5uA burnout current source to the PGA positive input when set to '1'. Default '0' disables the current source.
1	тѕ	Switches PGA input to temperature sensor when set to '1'. Default '0' uses VINx as PGA input
0	BGPCP	Disables bandgap chopper when set to '1'. Default '0' enables the bandgap chopper.

11.9 REG0x12-REG0x14: ADC Conversion Result

REG0x12 (Read Only)	ADCO_B2	ADC Conversion Result bit 23 to bit 16
REG0x13 (Read Only)	ADCO_B1	ADC Conversion Result bit 15 to bit 8
REG0x14 (Read Only)	ADCO_B0	ADC Conversion Result bit 7 to bit 0

Before reading an ADC Conversion Result, check if REG0x00 bit 5 CR=1 or DRDY pin showing Data Ready first. If not showing Data Ready, but a read of REG0x12 is performed, it will latch and shift out the previous conversion result.

There are two options are necessary read a complete 24 bit ADC conversion result:

Option 1: Use "I2C Burst Read 3 bytes"

Issue I2C burst read 3 bytes sequence with starting address 0x12. In read data section of this burst read sequence, continuously read 3 bytes of data, the first byte will be the bit 23 to bit 16, the second byte will be bit 15 to bit 8, the third byte will be bit 7 to bit 0 of the ADC conversion result.

Option 2: Use 3 "I2C Single Read"

Step 1: Read REG0x12: bit 23 to bit 16 ADC conversion result will be shift out

Step 2: Read REG0x13: bit 15 to bit 8 ADC conversion result will be shift out

Step 3. Read REG0x14: bit 7 to bit 0 ADC conversion result will be shift out

Note: The full 24-bit ADC conversion result is latched when the read REG0x12 command is decoded by the NAU7802. The following read of R0x13 and R0x14 will shift out the remainder of the latched ADC conversion result. This guarantees the 3 bytes of the data are from the same ADC sample conversion.

11.10 REG0x15: ADC registers

Bit	Name		De	escription	
		Select the CL	K_CHP clock	frequency.	
		REG_CPHS[1] REG_CPHS	0] CLK_CHP clock frequency	
5 .4	REG_CHPS	0 0		Reserved	
5:4	REG_CHPS	0 1		Reserved	
		1 0		Reserved	
		1	1	turned off, high ('1') state	
		Select the AD configuration.	-	non mode for unipolar	
		ADC_VCM[1]	ADC_VCM[0]	CHP_CLKSD Delay	2
		0	0	disable	
		0	1	disable	
3:2	3:2 ADC_VCM	1	0	Enable extended common mode. <u>When</u> voltage range close to REFN with ADC gain divided by 2. Reduced common mode rejection. Requires PGA bypass mode set.	J
		1	1	Enable extended common mode. <u>When</u> voltage range close to REFF with ADC gain divided by 2. Reduced common mode rejection. Requires PGA bypass mode set	2
1:0		Select delay between ADC clock (CLKSD) and ADC chopper clock (CHP_CLKSD). Clock delay variance between Chopper and ADC sections can improve linearity of the application.			

- Issue an I2C write REG0x15 with write data will update the ADC registers.
 For reading back ADC registers, make sure REG0x1B[7] RD_OTP_SEL=0 (default), then issue a I2C read REG0x15 to read ADC registers
- ADC registers and OTP[32:24] are sharing REG0x15 when read back, the REG0x1B[7] RD_OTP_SEL (default 0) is used as read select

REG0x15 Read	REG0x1B[7]=RD_OTP_SEL=1	Read back OTP[32:24]
REG0x15 Read	REG0x1B[7]=RD_OTP_SEL=0(default)	Read back ADC Registers(default)

REG0x15-REG0x17: OTP Read Value and REG0x15 ADC Registers Read

• ADC registers and OTP[32:24] are sharing REG0x15 when read back, the REG0x1B[7] RD_OTP_SEL (default 0) is used as read select

REG0x15 Read	REG0x1B[7]=RD_OTP_SEL=1	Read back OTP[32:24]
REG0x15 Read	REG0x1B[7]=RD_OTP_SEL=0(default)	Read back ADC Registers(default)
REG0x16 Read		Read back OTP[23:16]
REG0x17 Read		Read back OTP[15:8]

- 11.11REG0x18: Read Only
- 11.12REG0x19: Read Only
- 11.13REG0x1A: Read Only
- 11.14REG0x1B: PGA Registers

Bit	Name	Description
7	RD_OTP_SEL	Read REG0x15 output select 1: Read REG0x15 will read OTP[31:24] 0: Read REG0x15 will read ADC Registers
6	LDOMODE	 improved stability and lower DC gain, can accommodate ESR < 5 ohms (output capacitance) improved accuracy and higher DC gain, with ESR < 1 ohm.
5	PGA output buffer enable	1:PGA output buffer enable 0:PGA output buffer disable
4	PGA bypass enable	1:PGA bypass enable 0:PGA bypass disable
3	PGAINV	1: invert PGA input phase 0: default
2	Reserved	0: default
1	Reserved	0: default
0	PGACHPDIS	1: Chopper disabled 0: default

11.15 REG0x1C: POWER CONTROL Register

Bit	Name	Description
7	PGA_CAP_EN	Enables PGA output bypass capacitor connected across pins Vin2P Vin2N
6:4	MASTER_BIAS_CURR	MASTER_BIAS_CURR[2:0] Master bias Current 0 0 0 100% (default) 0 0 1 90% (lower power & accuracy) 0 1 0 80% 0 1 1 73% 1 0 0 67% 1 0 1 62% 1 1 0 58% 1 1 1 54%
3:2	ADC_CURR	ADC_CURR[1:0] ADC Current 0 0 100% of master bias 0 1 75% of master bias 1 0 50% of master bias 1 1 25% of master bias
1:0	PGA_CURR	PGA_CURR[1:0] PGA Current 0 0 100% of master bias (default) 0 1 95% of master bias (lower power & accuracy) 1 0 86% of master bias 1 1 70% of master bias

11.15.1 REG0x1D: Read Only

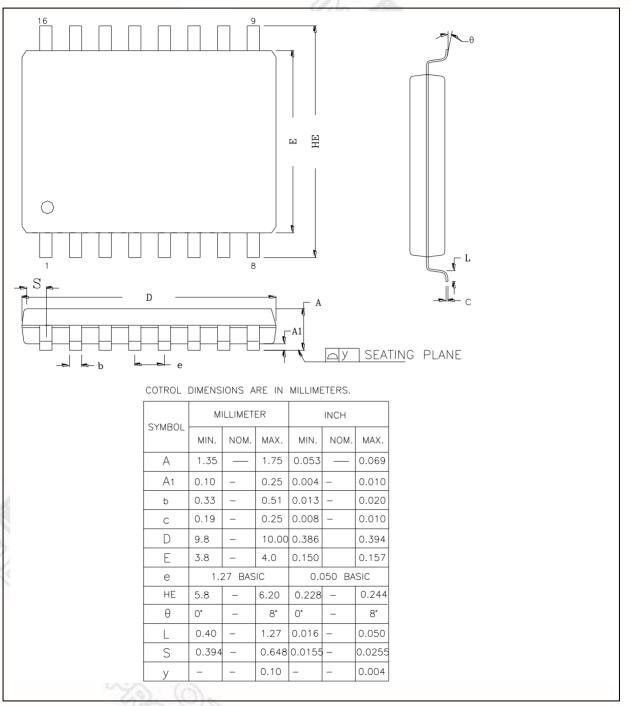
11.15.2REG0x1E: Read Only

11.15.3REG0x1F: Read Only

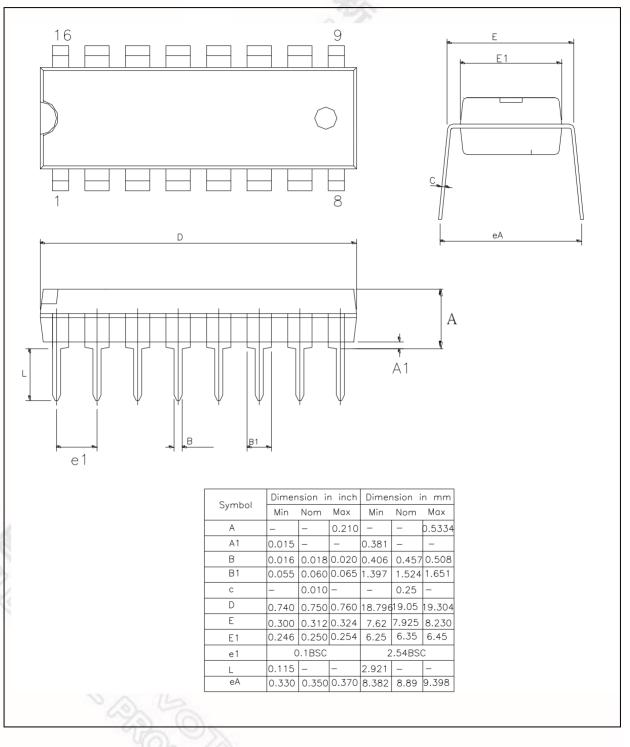
Bit	Name	Description
7:4	Reserved	MFG TEST
3:0	Revision ID	Chip Revision ID 1 1 1 1
2	D.	
fident	ial	- 37 - R

12 PACKAGE DIMENSIONS

12.1 16L SOP - 150 mil



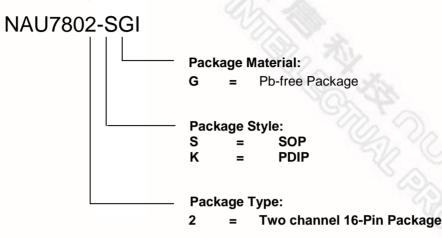
12.2 PDIP16L - 300 mil





13 PART ORDERING INFORMATION

Nuvoton Part Number Description





Revision 1.7

VERSION	DATE	PAGE	DESCRIPTION
V0.9	19Jul2010	-	Preliminary release general update
V099a	31 August 2010	-	Revise Electrical Characteristics, DC Electrical, System Performance, Voltage Reference, Digital Serial Interface, Add 2-Wire (draft related) timing, and bus loading I2C address 0x2A binary shown as "010 1010" Add I2C burst mode Add I2C Streaming mode, formerly named "special mode" Add typical I2C pull up resistor strong and weak ohms 0x11 Add application setting of register 0x00 = 0xAE Add Trdy AC typical specification Update registers 0x15, 0x1B, 0x1C, for revision A & later Add register 0x1F, silicon revision ID level Update package drawings Add part ordering numbering information
V 1.0	2 September 2010	-	Revised I2C section Add signal path and gain equations, normal and PGA bypass Add calibration equations Add Temperature sensor electrical spec 7.4 Add VOH spec distinct for DRDY,SDIO,SCLK Revise pin descriptions for DRDY,SDIO,SCLK Add PGA common mode range spec
V 1.1	7 October 2010	-	Update ENOB Update I2C streaming data mode entry Update power up initialization Update application diagram & description Update Register descriptions
V 1.2	27 October 2010	-	Update electrical characteristics Update register 0x1B description
V 1.3	December 2010	-	Added CRSD / FRD bits to Reg0x11 Register Description. Shortened names of the individual bits.
V 1.4	January 2011	-	Added Linearity / Noise / ESD Characteristic
V 1.5	February 2011	-	Update Characteristic Explanation
V 1.6	April 2011	-	Update PGA Input Range
V 1.7	January 2012		Update the Table of Contents

14 REVISION HISTORY

Important Notice

Nuvoton Products are neither intended nor warranted for usage in systems or equipment, any malfunction or failure of which may cause loss of human life, bodily injury or severe property damage. Such applications are deemed, "Insecure Usage".

Insecure usage includes, but is not limited to: equipment for surgical implementation, atomic energy control instruments, airplane or spaceship instruments, the control or operation of dynamic, brake or safety systems designed for vehicular use, traffic signal instruments, all types of safety devices, and other applications intended to support or sustain life.

All Insecure Usage shall be made at customer's risk, and in the event that third parties lay claims to Nuvoton as a result of customer's Insecure Usage, customer shall indemnify the damages and liabilities thus incurred by Nuvoton.

Please note that all data and specifications are subject to change without notice. All the trademarks of products and companies mentioned in this datasheet belong to their respective owners.

- 42 -

Revision 1.7